

SHEET 1 OF 2 S-111 (440-modified)		ATTY DOCKET NO. WATK:211	SEARCH NO. No application			
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		APPLICANT Yukihito ICHIKAWA et al.				
LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)		FILING DATE April 20, 2001	GROUP 1764			
U.S. PATENT DOCUMENTS						
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>My</i>	4,992,233	2/1991	Swaroop et al.	419	2	
	5,316,577	5/1994	Wu	106	189.1	
	4,979,364	12/1990	Fleck	60	274	
	5,460,865	10/1995	Tsotsis	428	116	
<i>HJ</i>	4,928,485	5/1990	Whittenberger	422	180	
<i>My</i>	5,852,982	12/1998	Iuei			
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION NO YES
<i>My</i>	10-59784	3/1998	Japan			x
	61-68141	4/1986	Japan			x
	5-123580	5/1993	Japan			x
	1-73336	5/1989	Japan			x
	0 886 040	12/1998	Europe			Abstract
	9-222009	8/1997	Japan			x
	9-151722	6/1997	Japan			x
	7-265652	10/1995	Japan			x
<i>My</i>	8-283002	10/1996	Japan			x
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)						
EXAMINER:	<i>Hien Tran</i>			DATE CONSIDERED: 1/21/05		

EXAMINER initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication - 10251crt

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NO.  
Application 09 / 830030

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FORM PTO-1449 (modified)		ATTY DOCKET NO WATK.211	SERIAL NO 09/630,030			
U S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE <i>DIPS</i> LIST OF REFERENCES CITED BY APPLICANT(S) <i>(Use several sheets if necessary)</i>		APPLICANT Yukihiro ICHIKAWA et al.				
<i>JUN 17 2002</i>		FILING DATE April 20, 2001	GROUP 1764			
U.S. PATENT DOCUMENTS						
EXAMINER <i>WY</i>	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>WY</i>	4,845,073	07/04/1989	Cyran	502	439	
<i>WY</i>	4,318,888	03/09/1982	Chapman et al.	422	180	
<i>WY</i>	5,853,902	12/29/1998	Usui	428	593	
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION NO YES
<i>WY</i>	WO 97/45200	12/04/1997	WIPO			
<i>WY</i>	0 389 750	10/03/1990	EPO			Abstract
<i>WY</i>	0 886 040	12/23/1998	EPO	<i>JUN 18 2002</i>	<i>RECEIVED</i>	
				<i>TC 1700</i>		
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)						

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